Applicant(s)/Patent Under Application/Control No. Reexamination 10/727,043 TANABE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3735 Karen E. Toth **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 600/485 US-6,884,221 04-2005 Narimatsu et al. Α 600/500 01-2003 Narimatsu, Kiyoyuki US-2003/0004422 В 600/490 Tampo et al. 05-2003 US-2003/0083580 С US-D US-Ε US-F US-G US-Н US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν O Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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